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**PATENT**  
29250-000750/US

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant: Robert E. MYER Conf. No. 2373  
Application No.: 09/656,933 Group No. 2829  
Filing Date: September 7, 2000 Examiner: Jimmy Nguyen  
Title: IMPROVED RF TEST PROBE

**AMENDMENT UNDER 37 C.F.R. §1.116**

Commissioner of Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

July 8, 2003

Sir:

Responsive to the Office Action mailed April 9, 2003, the following amendments and remarks are respectfully submitted in connection with the above-identified application.

**Amendments to the claims** begin on page 2 of this paper.

**Remarks** begin on page 6 of this paper.

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